

TOSHIBA MOS MEMORY PRODUCTS

262,144 WORD x 4 BIT DYNAMIC RAM

SILICON GATE CMOS

TC514258P/J/Z-85, TC514258P/J/Z-10
TC514258P/J/Z-12

DESCRIPTION

The TC514258P/J/Z is the new generation dynamic RAM organized 262,144 words by 4 bits. The TC514258P/J/Z utilizes TOSHIBA's CMOS Silicon gate process technology as well as advanced circuit techniques to provide wide operating margins, both internally and to the system user. Multiplexed address inputs permit the TC514258P/J/Z to be packaged in a standard 20 pin

plastic DIP and 20/26 pin plastic SOJ and 20/19 pin plastic ZIP. The package size provides high system bit densities and is compatible with widely available automated testing and insertion equipment. System oriented features include single power supply of $5V \pm 10\%$ tolerance, direct interfacing capability with high performance logic families such as Schottky TTL.

FEATURES

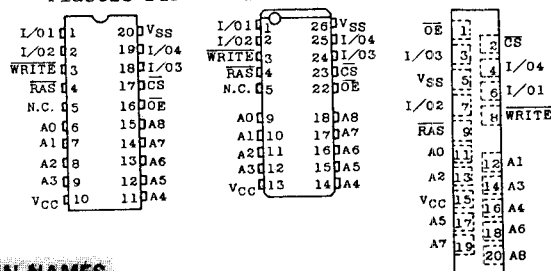
- 262,144 word by 4 bit organization
- Fast access time and cycle time

		TC514258P/J/Z-85-10-12		
t_{RAC}	RAS Access Time	85ns	100ns	120ns
t_{AA}	Column Address Access Time	45ns	50ns	60ns
t_{CAC}	CS Access Time	30ns	30ns	35ns
t_{RC}	Cycle Time	165ns	190ns	220ns
t_{SC}	Static Column Mode Cycle Time	50ns	55ns	65ns

- Single power supply of $5V \pm 10\%$ with a built-in V_{BB} generator

PIN CONNECTION (TOP VIEW)

• Plastic DIP • Plastic SOJ • Plastic ZIP

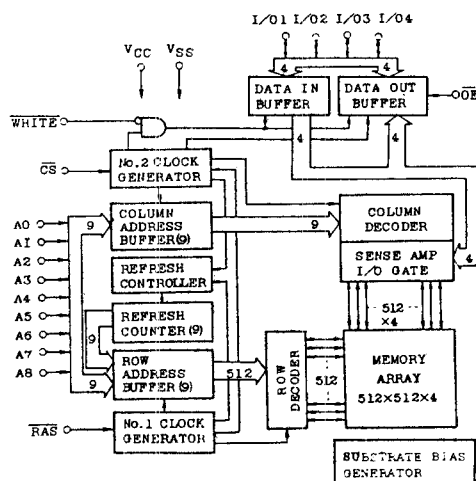


PIN NAMES

A0 ~ A8	Address Inputs
RAS	Row Address Strobe
CS	Chip Select
WRITE	Read/Write Input
OE	Output Enable
I/O1 ~ I/O4	Data Input/Output
V _{CC}	Power (+5V)
V _{SS}	Ground
N.C.	No Connection

- Low Power
413mW MAX. Operating (TC514258P/J/Z-85)
358mW MAX. Operating (TC514258P/J/Z-10)
303mW MAX. Operating (TC514258P/J/Z-12)
5.5mW MAX. Standby
- Outputs unlatched at cycle end allows two-dimensional chip selection
- Read-Modify-Write, $\overline{CS}$ before $\overline{RAS}$ refresh, $\overline{RAS}$ -only refresh, Hidden refresh and Static Column Mode capability
- All inputs and outputs TTL compatible
- 512 refresh cycles/8ms
- Package Plastic DIP : TC514258P
Plastic SOJ : TC514258J
Plastic ZIP : TC514258Z

BLOCK DIAGRAM



TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

ABSOLUTE MAXIMUM RATINGS

ITEM	SYMBOL	RATING	UNITS	NOTES
Input Voltage	V_{IN}	-1 ~ 7	V	1
Output Voltage	V_{OUT}	-1 ~ 7	V	1
Power Supply Voltage	V_{CC}	-1 ~ 7	V	1
Operating Temperature	T_{OPR}	0 ~ 70	°C	1
Storage Temperature	T_{STG}	-55 ~ 150	°C	1
Soldering Temperature*Time	T_{SOLDER}	260•10	°C•sec	1
Power Dissipation	P_D	600	mW	1
Short Circuit Output Current	I_{OUT}	50	mA	1

RECOMMENDED DC OPERATING CONDITIONS (Ta = 0 ~ 70°C)

SYMBOL	PARAMETER	MIN.	TYP.	MAX.	UNIT	NOTES
V_{CC}	Supply Voltage	4.5	5.0	5.5	V	2
V_{IH}	Input High Voltage	2.4	—	6.5	V	2
V_{IL}	Input Low Voltage	-1.0	—	0.8	V	2

DC ELECTRICAL CHARACTERISTICS ($V_{CC} = 5V \pm 10\%$, Ta = 0 ~ 70°C)

SYMBOL	PARAMETER	MIN.	UNIT	UNITS	NOTES
I_{CC1}	OPERATING CURRENT	TC514258P/J/Z-85	—	75	mA 3, 4
	Average Power Supply Operating Current (RAS, CS, Address Cycling: $t_{RC} = t_{RC MIN.}$)	TC514258P/J/Z-10	—	65	
		TC514258P/J/Z-12	—	55	
I_{CC2}	STANDBY CURRENT Power Supply Standby Current (RAS = CS = V_{IH})	—	2	mA	
I_{CC3}	RAS ONLY REFRESH CURRENT	TC514258P/J/Z-85	—	75	mA 3
	Average Power Supply Current, RAS Only Mode (RAS Cycling, CS = V_{IH} : $t_{RC} = t_{RC MIN.}$)	TC514258P/J/Z-10	—	65	
		TC514258P/J/Z-12	—	55	
I_{CC4}	STATIC COLUMN MODE CURRENT	TC514258P/J/Z-85	—	55	mA 3, 4
	Average Power Supply Current, Static Column Mode (RAS = CS = V_{IL} , Address Cycling: $t_{SC} = t_{SC MIN.}$)	TC514258P/J/Z-10	—	45	
		TC514258P/J/Z-12	—	35	
I_{CC5}	STANDBY CURRENT Power Supply Standby Current (RAS = CS = $V_{CC} - 0.2V$)	—	1	mA	
I_{CC6}	CS BEFORE RAS REFRESH CURRENT	TC514258P/J/Z-85	—	75	mA
	Average Power Supply Current, CS Before RAS Mode (RAS, CS Cycling: $t_{RC} = t_{RC MIN.}$)	TC514258P/J/Z-10	—	65	
		TC514258P/J/Z-12	—	55	
$I_{I(L)}$	INPUT LEAKAGE CURRENT Input Leakage Current, any input ($0V \leq V_{IN} \leq 6.5V$, All Other Pins Not Under Test = 0V)	-10	10	μA	
$I_{O(L)}$	OUTPUT LEAKAGE CURRENT (D_{OUT} is disable, $0V \leq V_{OUT} \leq 5.5V$)	-10	10	μA	
V_{OH}	OUTPUT LEVEL Output "H" Level Voltage ($I_{OUT} = -5mA$)	2.4	—	V	
V_{OL}	OUTPUT LEVEL Output "L" Level Voltage ($I_{OUT} = 4.2mA$)	—	0.4	V	

TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS

(V_{CC} = 5V ± 10%, T_a = 0 ~ 70°C) (Notes 5, 6, 7)

SYMBOL	PARAMETER	TC514258P/ J/Z-85		TC514258P/ J/Z-10		TC514258P/ J/Z-12		UNIT	NOTES
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
t _{RC}	Random Read or Write Cycle Time	165	—	190	—	220	—	ns	
t _{RMW}	Read-Modify-Write Cycle Time	225	—	255	—	295	—	ns	
t _{SC}	Static Column Mode Cycle Time	50	—	55	—	65	—	ns	
t _{SRMW}	Static Column Mode Read-Modify-Write Cycle Time	125	—	135	—	160	—	ns	
t _{RAC}	Access Time from RAS	—	85	—	100	—	120	ns	8, 13
t _{CAC}	Access Time from CS	—	30	—	30	—	35	ns	8, 13
t _{AA}	Access Time from Column Address	—	45	—	50	—	60	ns	9, 14
t _{ALW}	Access Time from Last Write	—	85	—	95	—	115	ns	8, 15
t _{CLZ}	CS to Output in Low-Z	5	—	5	—	5	—	ns	8
t _{OFF}	Output Buffer Turn-off Delay	0	30	0	30	0	35	ns	9
t _{AOH}	Output Data Hold Time from Column Address	5	—	5	—	5	—	ns	
t _{OW}	Output Data Enable Time from WRITE	—	30	—	30	—	35	ns	
t _T	Transition Time (Rise and Fall)	3	50	3	50	3	50	ns	7
t _{RP}	RAS Precharge Time	70	—	80	—	90	—	ns	
t _{RAS}	RAS Pulse Width	85	10,000	100	10,000	120	10,000	ns	
t _{RASC}	RAS Pulse Width (Static Column Mode)	85	100,000	100	100,000	120	100,000	ns	
t _{RSH}	CS to RAS Hold Time	30	—	30	—	35	—	ns	
t _{CSH}	RAS to CS Hold Time	85	—	100	—	120	—	ns	
t _{CS}	CS Pulse Width	30	10,000	30	10,000	35	10,000	ns	
t _{CSC}	CS Pulse Width (Static Column Mode)	30	100,000	30	100,000	35	100,000	ns	
t _{RCD}	RAS to CS Delay Time	25	55	25	70	25	85	ns	13
t _{RAD}	RAS to Column Address Delay Time	20	40	20	50	20	60	ns	14
t _{CRP}	CS to RAS Precharge Time	10	—	10	—	10	—	ns	
t _{CPN}	CS Precharge Time	15	—	15	—	20	—	ns	
t _{CP}	CS Precharge Time (Static Column Mode)	10	—	10	—	15	—	ns	
t _{ASR}	Row Address Set-Up Time	0	—	0	—	0	—	ns	
t _{RAH}	Row Address Hold Time	15	—	15	—	15	—	ns	
t _{ASC}	Column Address Set-Up Time	0	—	0	—	0	—	ns	
t _{CAH}	Column Address Hold Time	20	—	20	—	25	—	ns	
t _{AWR}	Write Address Hold Time referenced to RAS	65	—	75	—	90	—	ns	
t _{AR}	Column Address Hold Time referenced to RAS	100	—	115	—	140	—	ns	
t _{RAL}	Column Address to RAS Lead Time	45	—	50	—	60	—	ns	
t _{AH}	Column Address Hold Time referenced to RAS Rise	10	—	10	—	15	—	ns	16
t _{LWAD}	Last Write to Column Address Delay Time	25	40	25	45	30	55	ns	17
t _{AHLW}	Last Write to Column Address Hold Time	85	—	95	—	115	—	ns	

TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

ELECTRICAL CHARACTERISTICS AND RECOMMENDED AC OPERATING CONDITIONS (Continued)

SYMBOL	PARAMETER	TC514258P/ J/Z-85		TC514258P/ J/Z-10		TC514258P/ J/Z-12		UNITS	NOTES
		MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
t_{RCS}	Read Command Set-Up Time referenced to $\overline{CS}$	0	—	0	—	0	—	ns	
t_{RCH}	Read Command Hold Time referenced to $\overline{CS}$	0	—	0	—	0	—	ns	10
t_{RRH}	Read Command Hold Time referenced to RAS	0	—	0	—	0	—	ns	10
t_{WH}	Write Command Hold Time (Output Data Disable)	0	—	0	—	0	—	ns	12
t_{WCR}	Write Command Hold Time referenced to RAS	65	—	75	—	90	—	ns	
t_{WP}	WRITE Pulse Width	20	—	20	—	25	—	ns	
t_{WI}	WRITE Inactive Time	10	—	10	—	15	—	ns	
t_{RWL}	WRITE Command to RAS Lead Time	20	—	25	—	30	—	ns	
t_{CWL}	WRITE Command to $\overline{CS}$ Lead Time	20	—	25	—	30	—	ns	
t_{DS}	Data-In Set-Up Time	0	—	0	—	0	—	ns	11
t_{DH}	Data-In Hold Time	20	—	20	—	25	—	ns	11
t_{DHR}	Data-In Hold Time referenced to RAS	65	—	75	—	90	—	ns	
t_{REF}	Refresh Period	—	8	—	8	—	8	ms	
t_{WS}	WRITE Command Set-Up Time (Output Data Disable)	0	—	0	—	0	—	ns	12
t_{CWD}	$\overline{CS}$ to WRITE Delay Time (READ-MODIFY-WRITE CYCLE)	65	—	65	—	75	—	ns	12
t_{RWD}	RAS to WRITE Delay Time (READ-MODIFY-WRITE CYCLE)	120	—	135	—	160	—	ns	12
t_{AWD}	Column Address to WRITE Delay Time	80	—	85	—	100	—	ns	12
t_{CSR}	$\overline{CS}$ Set-Up Time ($\overline{CS}$ before RAS)	10	—	10	—	10	—	ns	
t_{CHR}	$\overline{CS}$ Hold Time ($\overline{CS}$ before RAS)	30	—	30	—	30	—	ns	
t_{RPC}	RAS to $\overline{CS}$ Precharge Time	0	—	0	—	0	—	ns	
t_{CPT}	$\overline{CS}$ Precharge Time ($\overline{CS}$ before RAS Counter Test Cycle)	50	—	50	—	60	—	ns	
t_{ROH}	RAS Hold Time Referenced to $\overline{OE}$	20	—	20	—	20	—	ns	
t_{OEA}	$\overline{OE}$ Access Time	—	30	—	30	—	35	ns	
t_{OED}	$\overline{OE}$ to Data Delay	25	—	25	—	30	—	ns	
t_{OEZ}	Output Buffer turn off Delay Time from $\overline{OE}$	0	25	0	25	0	30	ns	
t_{OEH}	$\overline{OE}$ Command Hold Time	25	—	25	—	30	—	ns	

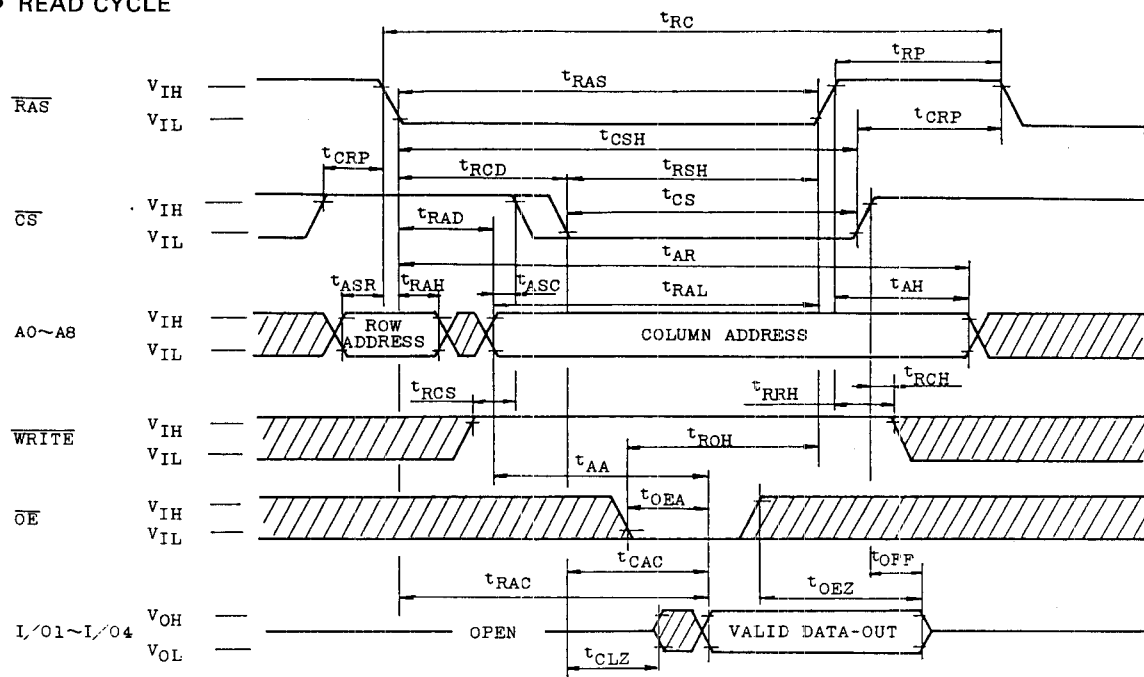
CAPACITANCE ($V_{CC} = 5V \pm 10\%$, $f = 1MHz$, $T_a = 0 \sim 70^\circ C$)

SYMBOL	PARAMETER	MIN.	MAX.	UNIT
C_{I1}	Input Capacitance ($A_0 \sim A_8$)	—	5	pF
C_{I2}	Input Capacitance (RAS, $\overline{CS}$, WRITE, $\overline{OE}$)	—	7	pF
C_O	Output Capacitance ($I/O_1 \sim I/O_4$)	—	7	pF

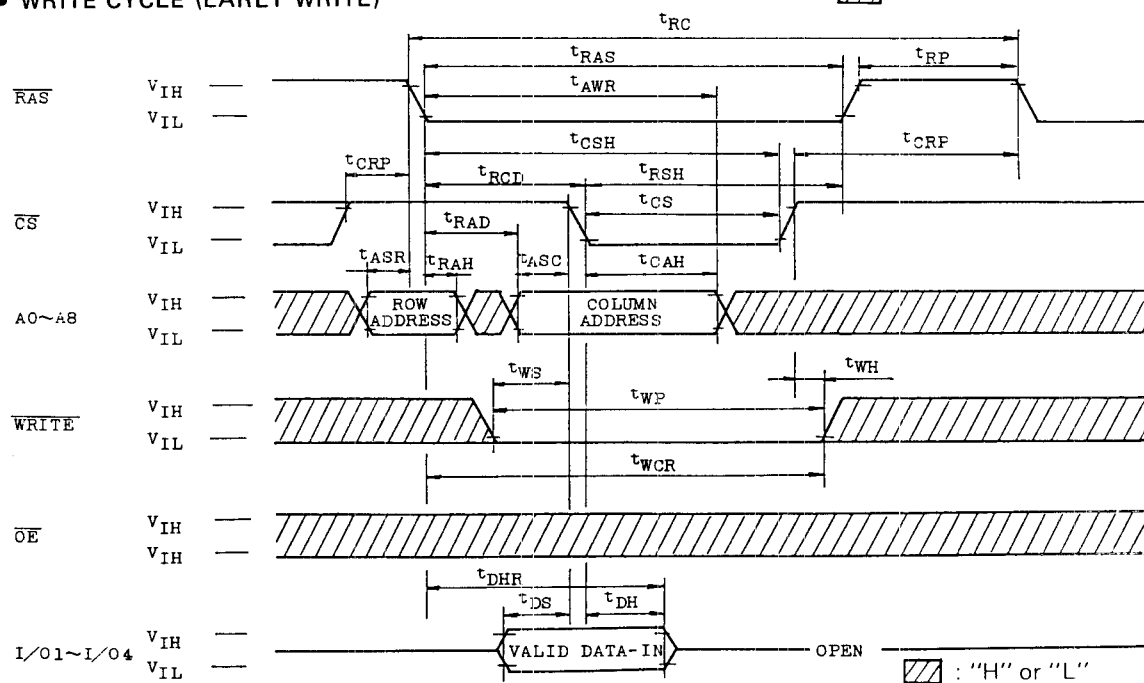
NOTES:

1. Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device.
2. All voltages are referenced to V_{SS} .
3. I_{CC1} , I_{CC3} , I_{CC4} , I_{CC6} depend on cycle rate.
4. I_{CC1} , I_{CC4} depend on output loading. Specified values are obtained with the output open.
5. An initial pause of $200\mu s$ is required after power-up followed by 8 $\overline{RAS}$ cycles before proper device operation is achieved. In case of using internal refresh counter, a minimum of 8 $\overline{CS}$ before $\overline{RAS}$ initialization cycles instead of 8 $\overline{RAS}$ cycles are required.
6. AC measurements assume $t_T = 5ns$.
7. V_{IH} (min.) and V_{IL} (max.) are reference levels for measuring timing of input signals.
8. Measured with a load equivalent to 2 TTL loads and 100pF.
9. t_{OFF} (max.) and t_{OEZ} (max.) define the time at which the output achieves the open circuit condition and is not referenced to output voltage levels.
10. Either t_{RCH} or t_{RRH} must be satisfied for a read cycle.
11. These parameters are referenced to $\overline{CS}$ leading edge in early write cycles and to $\overline{WRITE}$ leading edge in Read-Modify-Write cycles.
12. t_{WS} , t_{WH} , t_{RWD} , t_{CWD} and t_{AWD} are not restrictive operating parameters. They are included the data sheet as electrical characteristics only. If $t_{WS} \geq t_{WS}(\min.)$, the cycle is an early write cycle and data out pin will remain open circuit (high impedance) through the entire cycle; If $t_{RWD} \geq t_{RWD}(\min.)$, $t_{CWD} \geq t_{CWD}(\min.)$ and $t_{AWD} \geq t_{AWD}(\min.)$, the cycle is a Read-Modify-Wrete cycle and the data out will contain data read from the selected cell. If neither of the above sets of conditions is satisfied, the condition of the data out (at access time) is indeterminate.
13. Operation within the $t_{RCD}(\max.)$ limit insures that $t_{RAC}(\max.)$ can be met. $t_{RCD}(\max.)$ is specified as a reference point only: If t_{RCD} is greater than the specified $t_{RCD}(\max.)$ limit, then access time is controlled by t_{CAC} .
14. Operation within the $t_{RAD}(\max.)$ limit insures that $t_{RAC}(\max.)$ can be met. $t_{RAD}(\max.)$ is specified as a reference point only: If t_{RAD} is greater then the specified $t_{RAD}(\max.)$ limit, then access time is controlled by t_{AA} .
15. Operation within the $t_{LWAD}(\max.)$ limit insures that $t_{ALW}(\max.)$ can be met. $t_{LWAD}(\max.)$ is specified as a reference point only: If t_{LWAD} is greater than the specified $t_{LWAD}(\max.)$ limit, then access time is controlled exclusively by t_{AA} .
16. t_{AH} is the condition to latch column address when $\overline{RAS}$ has risen up.

• READ CYCLE

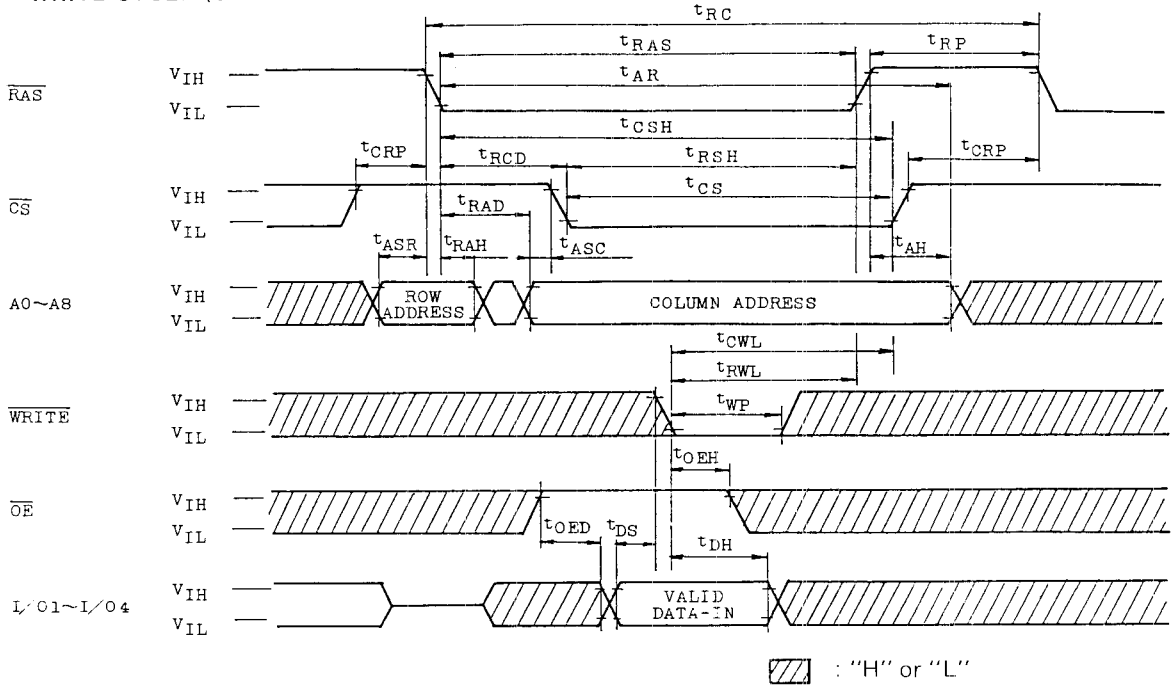


• WRITE CYCLE (EARLY WRITE)

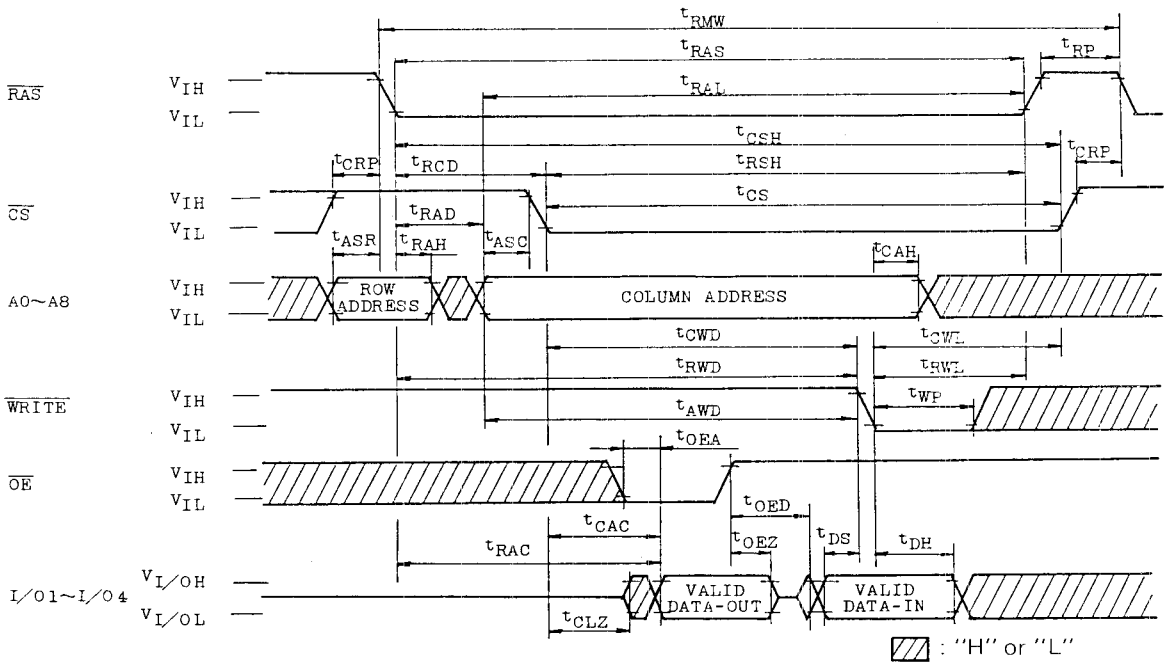


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• WRITE CYCLE ($\overline{OE}$ CONTROLLED WRITE)

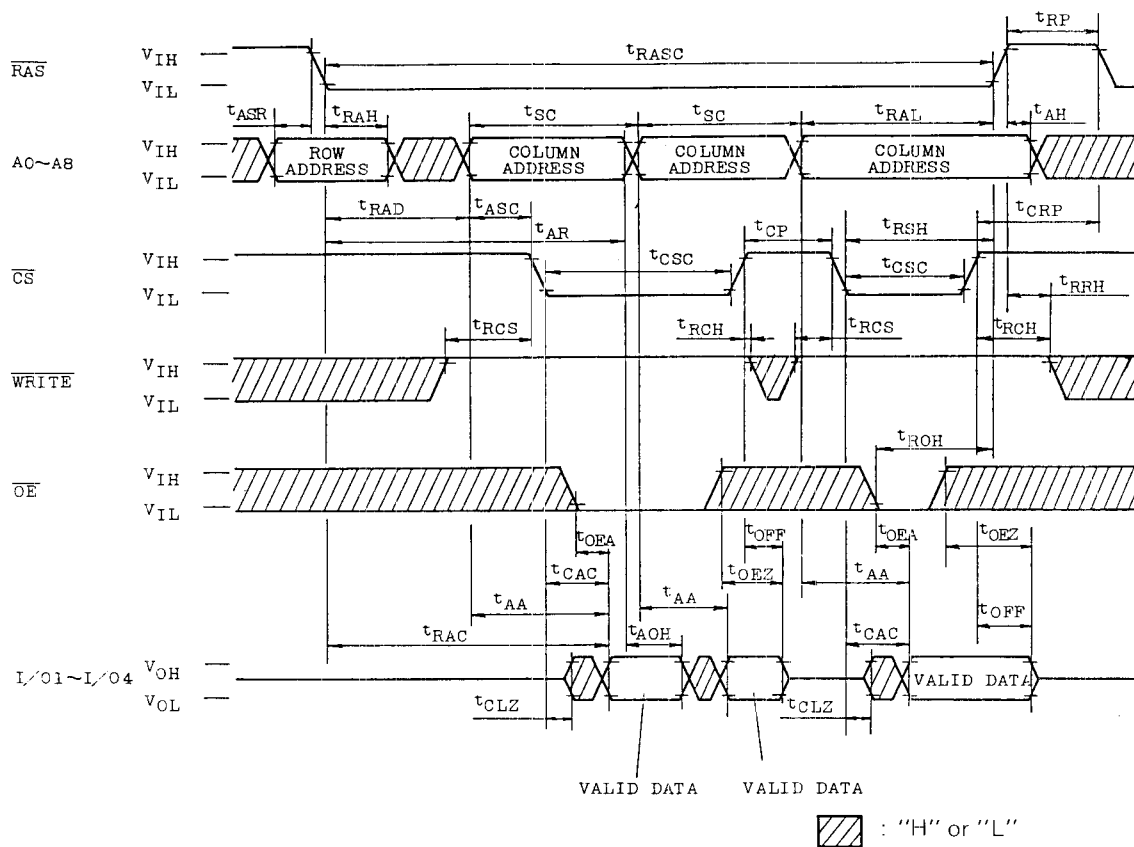


• READ-MODIFY-WRITE CYCLE



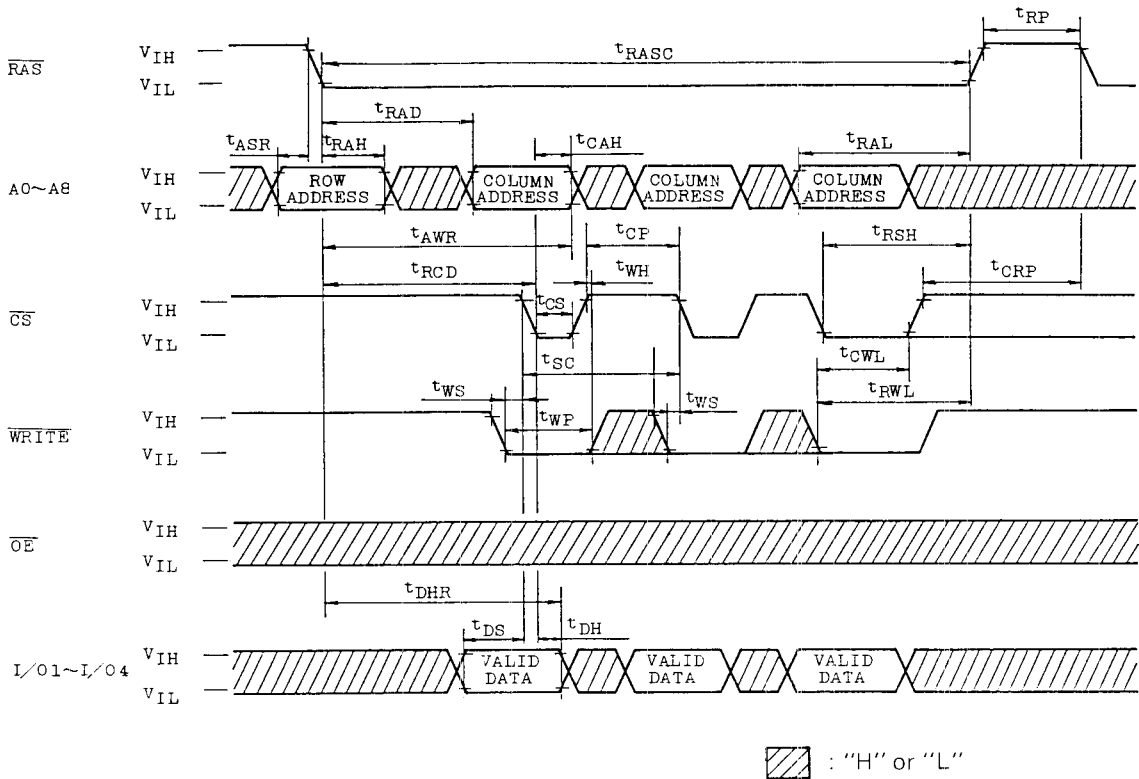
TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

• STATIC COLUMN MODE READ CYCLE



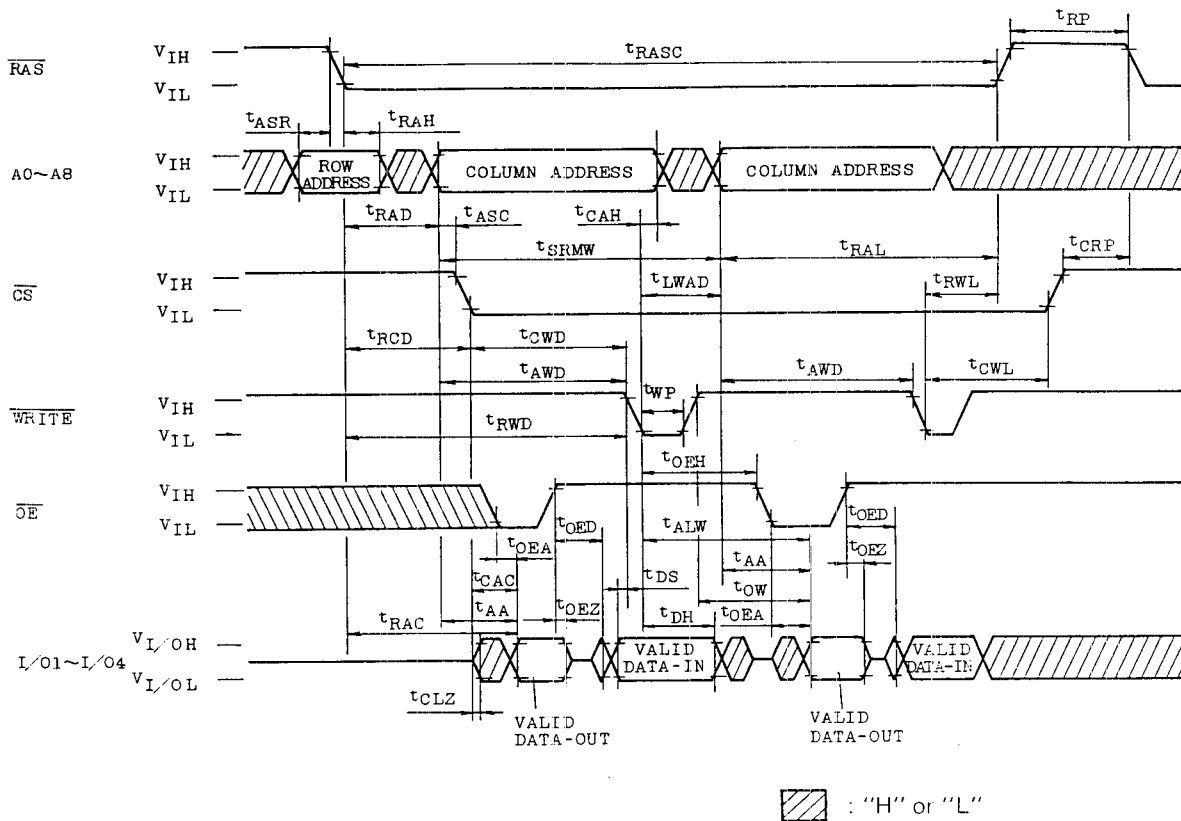
TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

• STATIC COLUMN MODE WRITE CYCLE (EARLY WRITE)



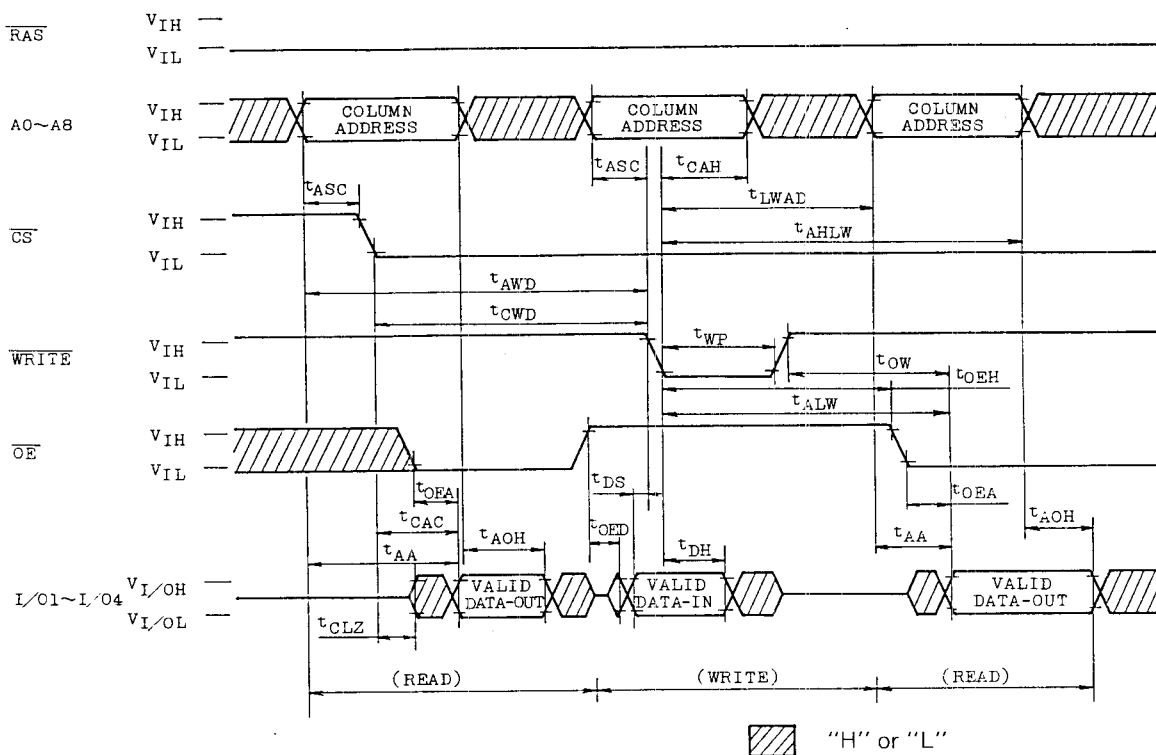
TC514258P/J/Z-85, TC514258P/J/Z-10 **TC514258P/J/Z-12**

• STATIC COLUMN MODE READ-MODIFY-WRITE CYCLE



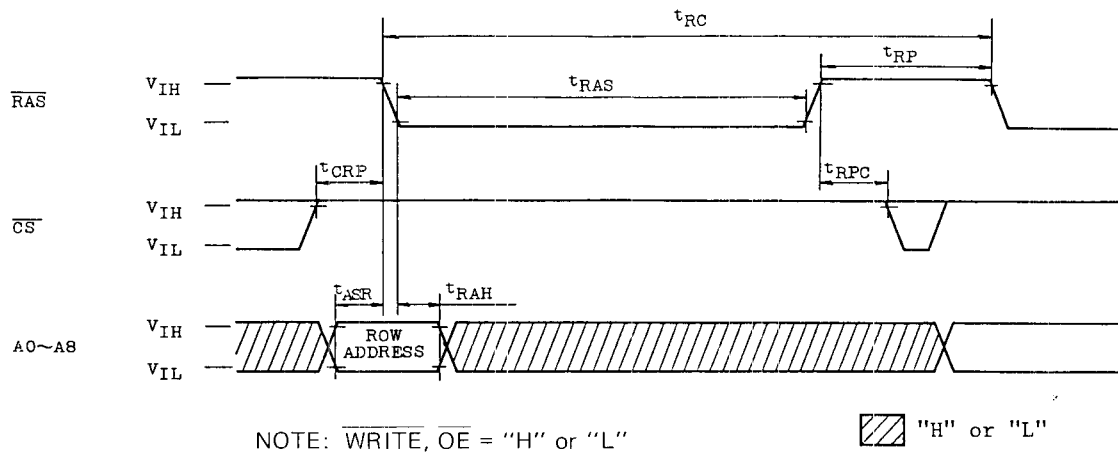
TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

• STATIC COLUMN MODE READ/WRITE MIXED CYCLE

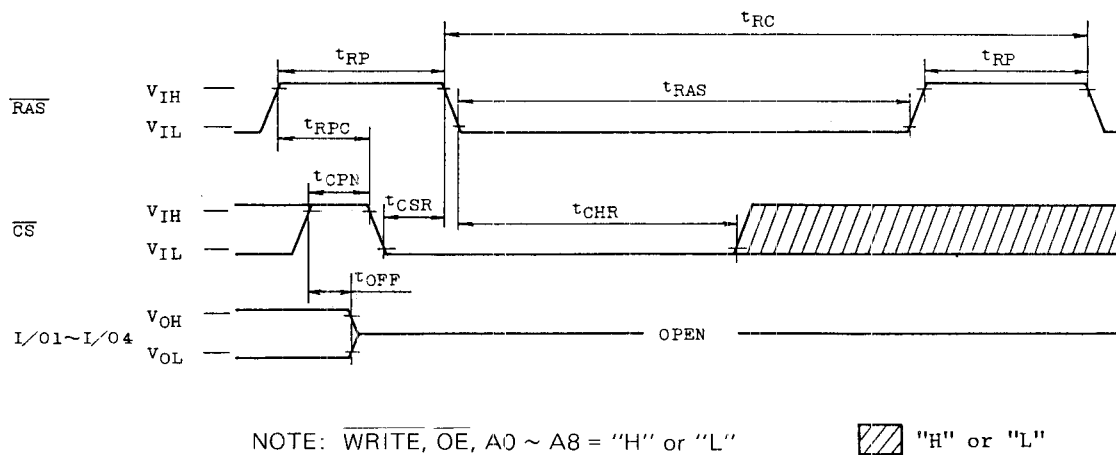


TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

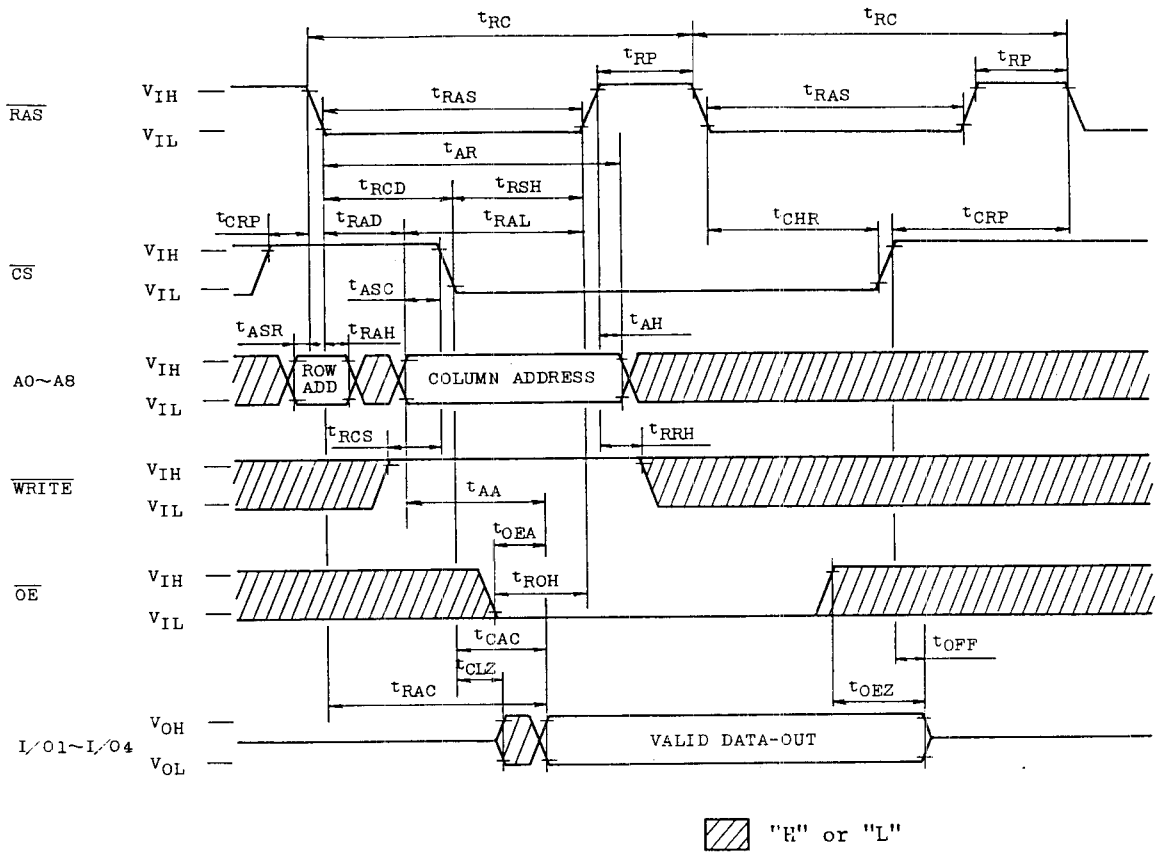
• $\overline{\text{RAS}}$ ONLY REFRESH CYCLE



• $\overline{\text{CS}}$ BEFORE $\overline{\text{RAS}}$ REFRESH CYCLE

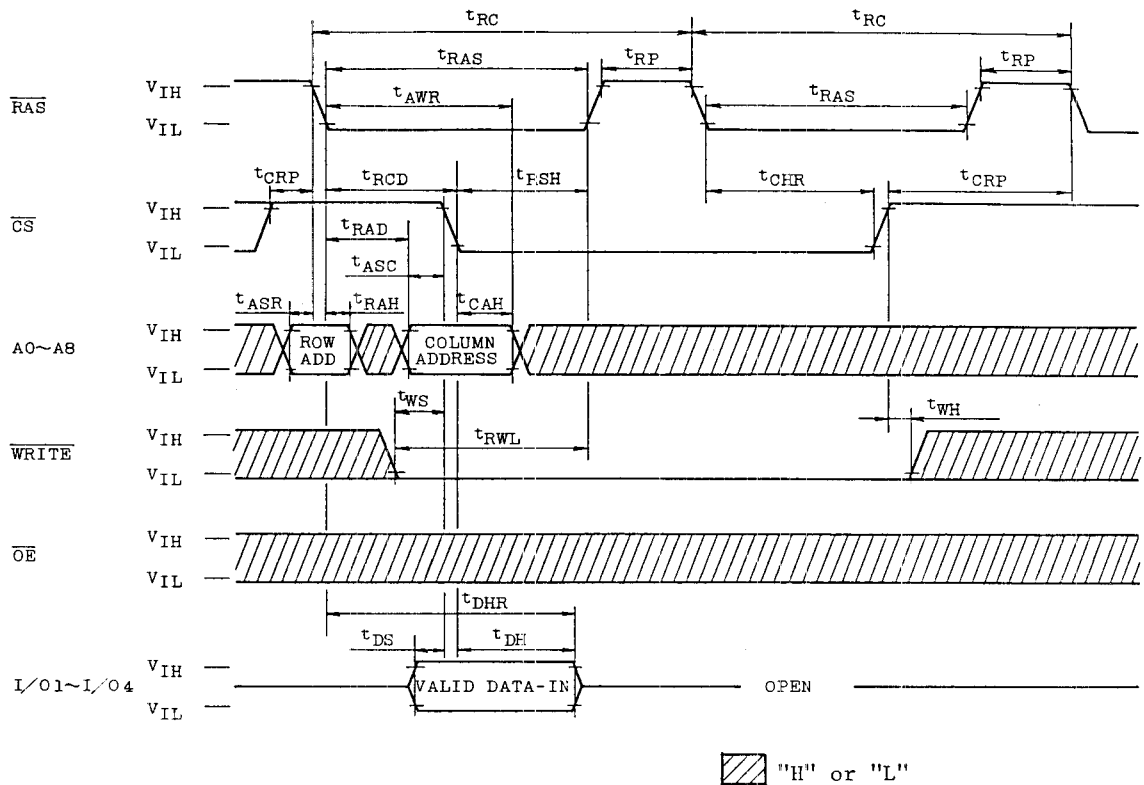


• HIDDEN REFRESH CYCLE (READ)



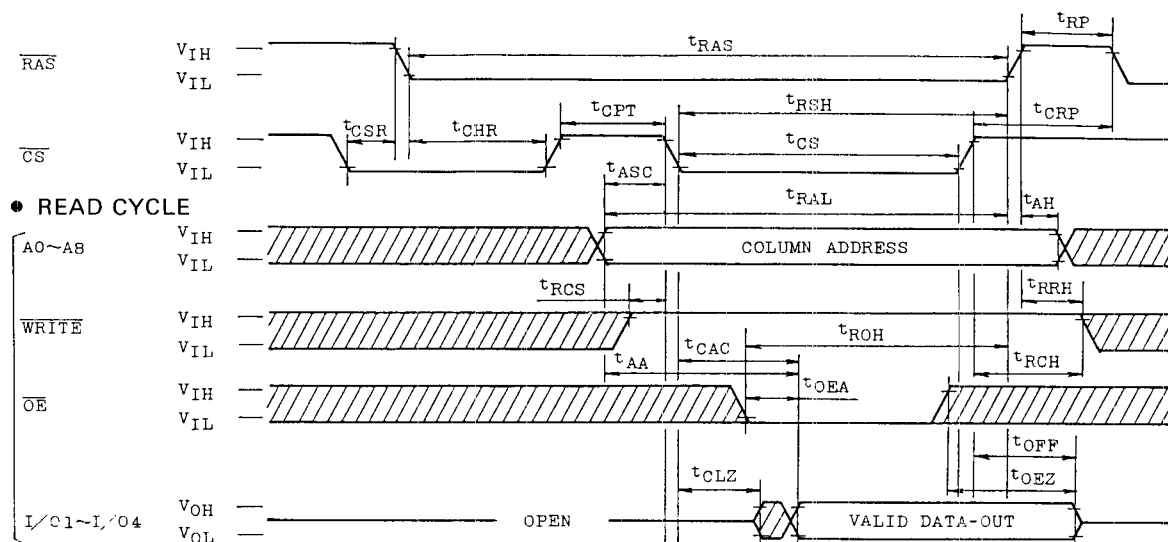
**TC514258P/J/Z-85, TC514258P/J/Z-10
TC514258P/J/Z-12**

• HIDDEN REFRESH CYCLE (WRITE)

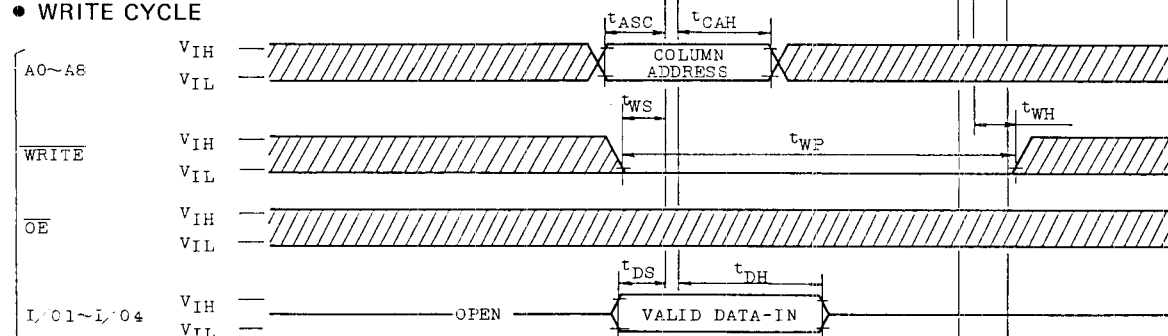


TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

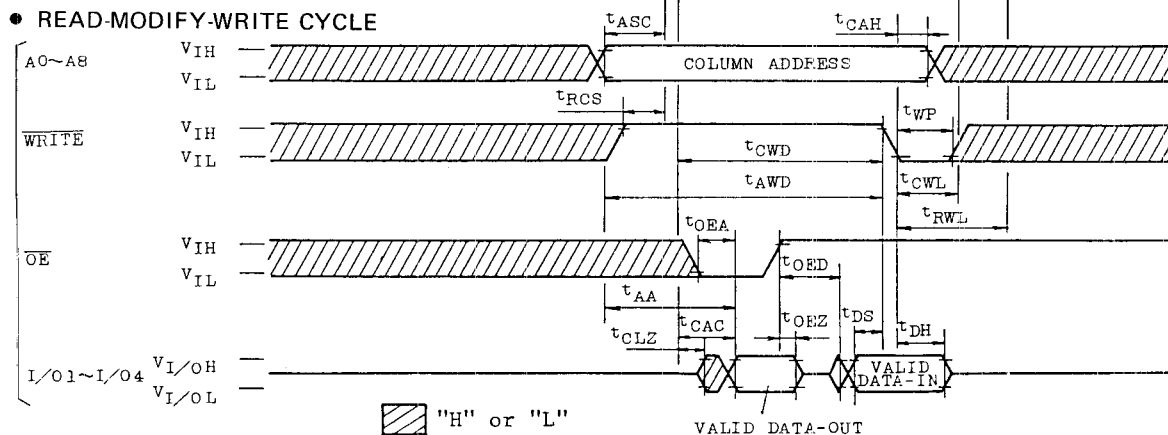
• $\overline{CS}$ BEFORE RAS REFRESH COUNTER TEST CYCLE



• WRITE CYCLE



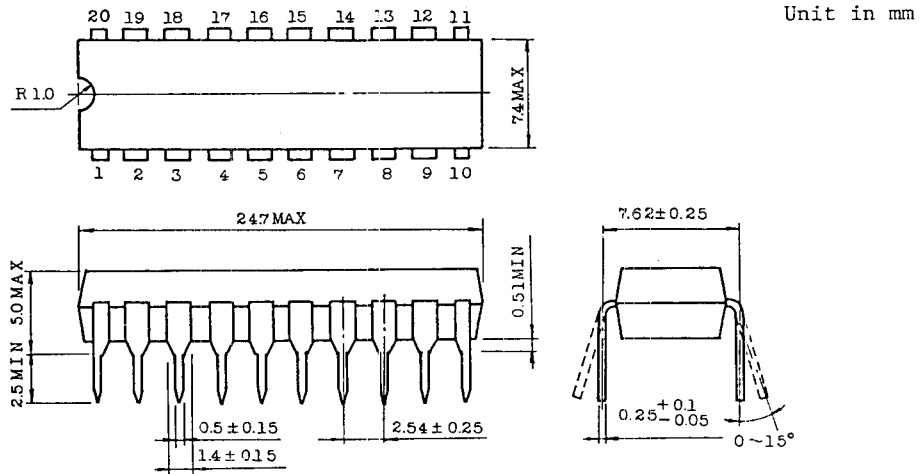
• READ-MODIFY-WRITE CYCLE



TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

OUTLINE DRAWINGS

- Plastic DIP

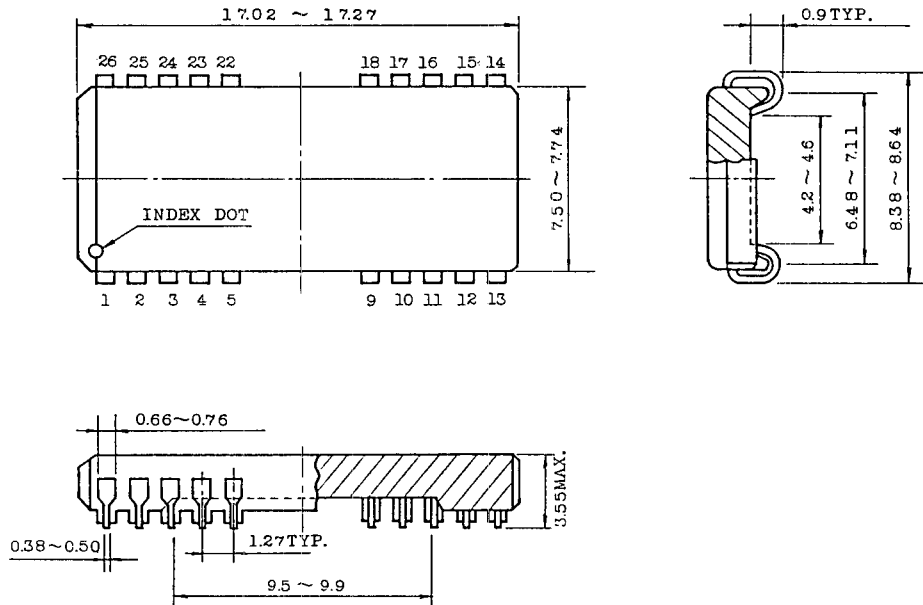


NOTE: Each lead pitch is 2.54mm.
All leads are located within 0.25mm of their true longitudinal position with respect to No. 1 and No. 20 leads.
All dimensions are in millimeters.

TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

- Plastic SOJ

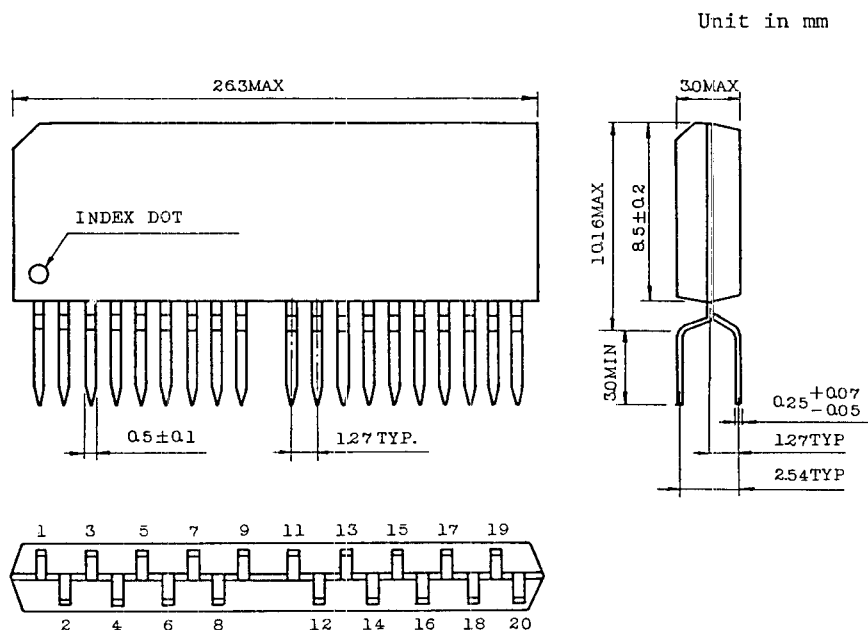
Unit in mm



NOTE: Each lead pitch 1.27mm. All dimensions are in millimeters.

TC514258P/J/Z-85, TC514258P/J/Z-10 TC514258P/J/Z-12

• Plastic ZIP



NOTE: Each lead pitch is 1.27mm.
All dimensions are in millimeters.
Toshiba does not assume any responsibility for use of any circuitry described;
no circuit patent licenses are implied, and Toshiba reserves the right, at any
time without notice, to change said circuitry.